

Search Notes

Application/Control No.

10/656,382

Examiner

Sunray Chang

Applicant(s)/Patent under
Reexamination

HASHIMOTO ET AL.

Art Unit

2121

SEARCHED

Class	Subclass	Date	Examiner
60	276,285	2/18/2006	SC
700	29	2/18/2006	SC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	2/18/2006	SC